Field Stop Trench IGBT 650 V, 40 A

FGHL40T65MQD

Field stop 4th generation mid speed IGBT technology and full current rated copak Diode technology.

Features

- Maximum Junction Temperature: $T_J = 175^{\circ}C$
- Positive Temperature Co-efficient for Easy Parallel Operating
- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 1.45 \text{ V (Typ.)}$ @ $I_C = 40 \text{ A}$
- 100% of the Parts are Tested for I_{LM} (Note 2)
- Smooth & Optimized Switching
- Tight Parameter Distribution
- RoHS Compliant

Typical Applications

- Solar Inverter
- UPS, ESS
- PFC, Converters

MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Collector-to-Emitter Voltage		V _{CES}	650	V
Gate-to-Emitter Voltage		V_{GES}	±20	V
Transient Gate-to-Emitter Voltage		V_{GES}	±30	V
Collector Current (Note 1)	T _C = 25°C	I _C	80	Α
	T _C = 100°C		40	
Pulsed Collector Current (Note 2)		I_{LM}	160	Α
Pulsed Collector Current (Note 3)	I _{CM}	160	Α	
Diode Forward Current (Note 1)	T _C = 25°C	ΙF	40	Α
	T _C = 65°C		25	
Pulsed Diode Maximum Forward C	I _{FM}	160	Α	
Non-Repetitive Forward Surge Cu (Half-Sine Pulse, t_p = 8.3 ms, T_C = (Half-Sine Pulse, t_p = 8.3 ms, T_C =	I _{F,SM}	85 80	Α	
Maximum Power Dissipation	T _C = 25°C	P _D	238	W
	T _C = 100°C		119	
Operating Junction and Storage Te Range	T _J , T _{stg}	-55 to +175	°C	
Maximum Lead Temperature for Soldering Purposes (1/8" from case for 5 s)		TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

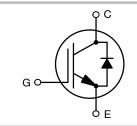
- 1. Value limit by bond wire
- 2. V_{CC} = 400 V, V_{GE} = 15 V, I_{C} = 160 A, R_{G} = 14 Ω , Inductive Load, 100% Tested 3. Repetitive rating: Pulse width limited by max. junction temperature

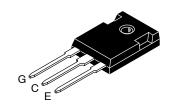


ON Semiconductor®

www.onsemi.com

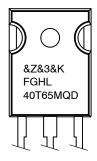
BV _{CES}	V _{CE(sat)} TYP	I _C MAX
650 V	1.45 V	40 A





TO-247 LONG LEADS CASE 340CX

MARKING DIAGRAM



= Assembly Plant Code &Z &3 = 3-Digit Date Code

&K = 2-Digit Lot Traceability Code

FGHL40T65MQD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGHL40T65MQD	TO-247-3L	30 Units / Rail

Table 1. THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-to-Case, for IGBT	$R_{\theta JC}$	0.63	°C/W
Thermal Resistance Junction-to-Case, for Diode	$R_{\theta JC}$	1.6	
Thermal Resistance Junction-to-Ambient	$R_{\theta JA}$	40	

Table 2. ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTIC				•	•	•
Collector-emitter breakdown voltage, gate-emitter short-circuited	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	BV _{CES}	650	-	-	V
Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0 \text{ V}, I_C = 1 \text{ mA}$	$\Delta BV_{CES}/\Delta T_{J}$	-	0.6	-	V/°C
Collector-emitter cut-off current, gate-emitter short-circuited	V _{GE} = 0 V, V _{CE} = 650 V	I _{CES}	-	-	250	μΑ
Gate leakage current, collector-emitter short-circuited	V _{GE} = 20 V, V _{CE} = 0 V	I _{GES}	-	-	±400	nA
ON CHARACTERISTIC						
Gate-emitter threshold voltage	$V_{GE} = V_{CE}$, $I_C = 40 \text{ mA}$	V _{GE(th)}	3.0	4.5	6.0	V
Collector-emitter saturation voltage	V_{GE} = 15 V, I_{C} = 40 A V_{GE} = 15 V, I_{C} = 40 A, T_{J} = 175°C	V _{CE(sat)}	_ _	1.45 1.77	1.8 -	V
DYNAMIC CHARACTERISTIC						
Input capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V}, f = 1 \text{ MHz}$	C _{ies}	-	2756	_	pF
Output capacitance		C _{oes}	-	64	-	1
Reverse transfer capacitance		C _{res}	-	9	-	
Gate charge total	V _{CE} = 400 V, I _C = 40 A, V _{GE} = 15 V	Qg	-	86	-	nC
Gate-to-Emitter charge		Q _{ge}	-	16	-	
Gate-to-Collector charge		Q _{gc}	-	21	-	
SWITCHING CHARACTERISTIC, IND	UCTIVE LOAD					
Turn-on delay time	T _C = 25°C	t _{d(on)}	-	20	_	ns
Rise time	$V_{CC} = 400 \text{ V}, I_C = 20 \text{ A}$ $R_G = 10 \Omega$	t _r	-	13	-	
Turn-off delay time	V _{GE} = 15 V Inductive Load	t _{d(off)}	-	116	_	
Fall time		t _f	-	51	-	
Turn-on switching loss		E _{on}	-	0.33	-	mJ
Turn-off switching loss		E _{off}	-	0.26	-	
Total switching loss		E _{ts}	-	0.59	-	
Turn-on delay time	T _C = 25°C	t _{d(on)}	-	22	-	ns
Rise time	$V_{CC} = 400 \text{ V}, I_{C} = 40 \text{ A}$ $R_{G} = 10 \Omega$	t _r	-	30	_	1
Turn-off delay time	V _{GE} = 15 V Inductive Load	t _{d(off)}	-	109	_]
Fall time		t _f	-	46	-	1
Turn-on switching loss		E _{on}	-	0.86	-	mJ
Turn-off switching loss		E _{off}	_	0.52	-	1
Total switching loss		E _{ts}	_	1.38	-	1

Table 2. ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Test Conditions	Symbol	Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC, IN	DUCTIVE LOAD	•		•		
Turn-on delay time	T _C = 175°C	t _{d(on)}	-	20	_	ns
Rise time	$V_{CC} = 400 \text{ V, } I_{C} = 20 \text{ A}$ $R_{G} = 10 \Omega$	t _r	_	14	-	
Turn-off delay time	V _{GE} = 15 V Inductive Load	t _{d(off)}	-	127	-	
Fall time	7	t _f	-	76	-	
Turn-on switching loss	7	E _{on}	-	0.60	-	mJ
Turn-off switching loss	7	E _{off}	-	0.42	-	
Total switching loss		E _{ts}	-	1.02	-	
Turn-on delay time	T_C = 175°C V_{CC} = 400 V, I_C = 40 A R_G = 10 Ω V_{GE} = 15 V Inductive Load	t _{d(on)}	-	20	-	ns
Rise time		t _r	-	32	-	
Turn-off delay time		t _{d(off)}	-	119	-	
Fall time		t _f	-	63	-	
Turn-on switching loss	7	E _{on}	-	1.28	-	mJ
Turn-off switching loss		E _{off}	-	0.77	-	
Total switching loss		E _{ts}	ì	2.05	-	
DIODE CHARACTERISTIC2.5						
Diode Forward Voltage	I _F = 40 A, T _C = 25°C I _F = 40 A, T _C = 175°C	V _{FM}	- -	2.55 2.3	2.85 -	V
Reverse Recovery Energy	$I_F = 40 \text{ A}, \text{ d}I_F/\text{d}t = 200 \text{ A}/\mu\text{s}, T_C = 175^{\circ}\text{C}$	E _{rec}	-	56	-	μJ
Diode Reverse Recovery Time	$I_F = 40 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_C = 25^{\circ}\text{C}$ $I_F = 40 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}, T_C = 175^{\circ}\text{C}$	T _{rr}	_	33 222	_	ns
Diode Reverse Recovery Charge	I_F = 40 A, dI_F/dt = 200 A/ μ s, T_C = 25°C I_F = 40 A, dI_F/dt = 200 A/ μ s, T_C = 175°C	Q _{rr}	-	47 759	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

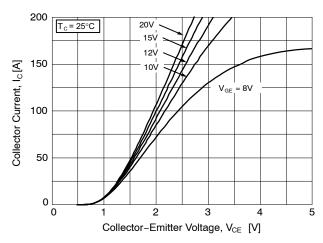


Figure 1. Typical Output Characteristics $(T_J = 25^{\circ}C)$

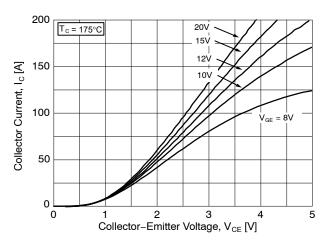


Figure 2. Typical Output Characteristics $(T_J = 175^{\circ}C)$

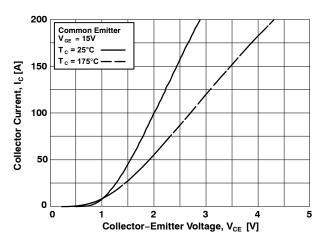


Figure 3. Typical Saturation Voltage Characteristics

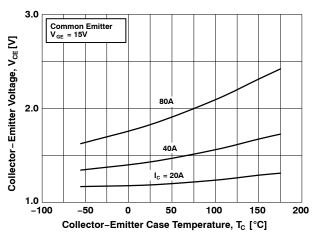


Figure 4. Saturation Voltage vs. Case Temperature at Variant Current Level

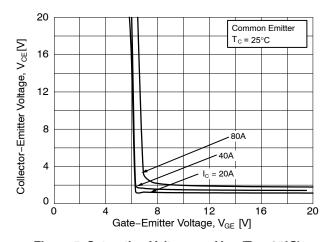


Figure 5. Saturation Voltage vs. V_{GE} (T_J = 25°C)

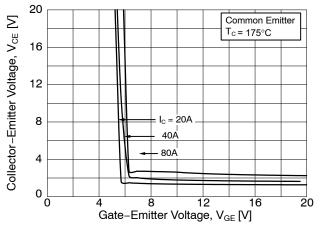


Figure 6. Saturation Voltage vs. V_{GE} (T_J = 175°C)

TYPICAL CHARACTERISTICS (continued)

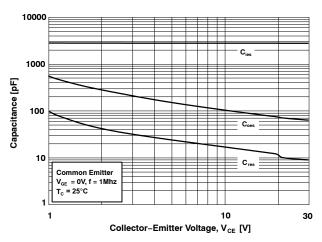


Figure 7. Capacitance Characteristics

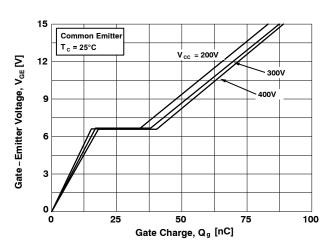


Figure 8. Gate Charge Characteristics

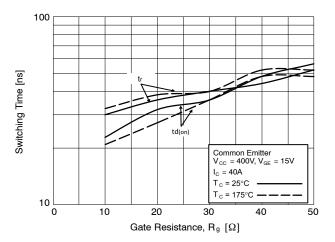


Figure 9. Turn-On Characteristics vs. Gate Resistance

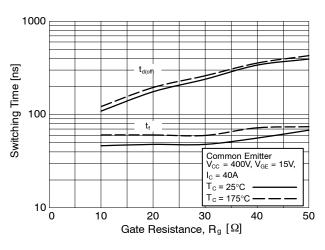


Figure 10. Turn-Off Characteristics vs. Gate Resistance

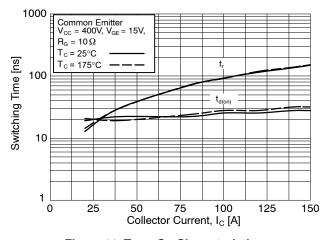


Figure 11. Turn-On Characteristics vs. Collector Current

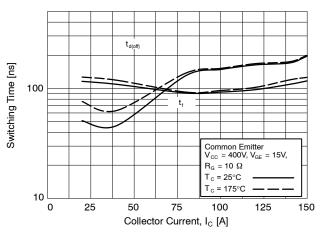


Figure 12. Turn-Off Characteristics vs. Collector Current

TYPICAL CHARACTERISTICS (continued)

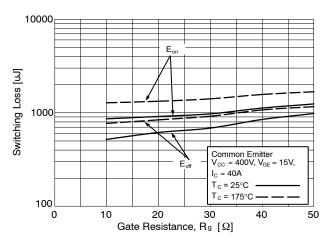


Figure 13. Switching Loss vs. Gate Resistance

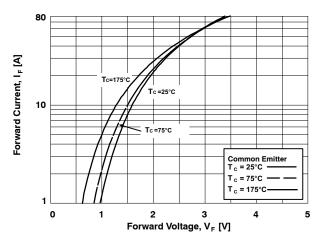


Figure 15. Forward Characteristics

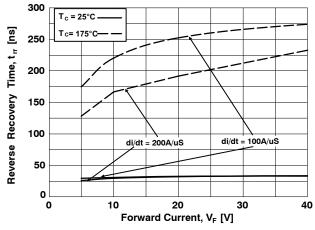


Figure 17. Reverse Recovery Time

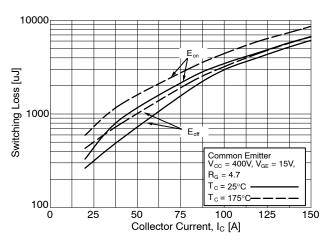


Figure 14. Switching Loss vs. Collector Current

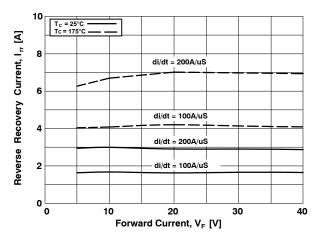


Figure 16. Reverse Recovery Current

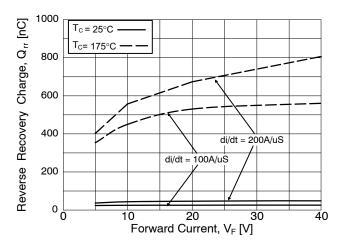


Figure 18. Stored Charge

TYPICAL CHARACTERISTICS (continued)

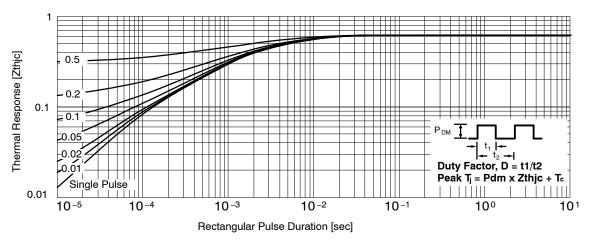


Figure 19. Transient Thermal Impedance of IGBT

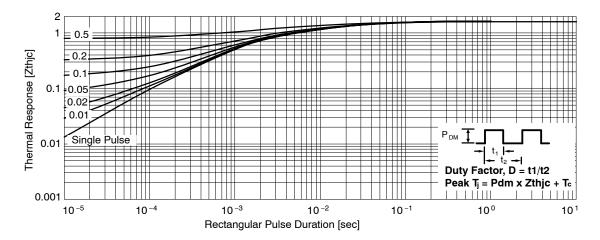
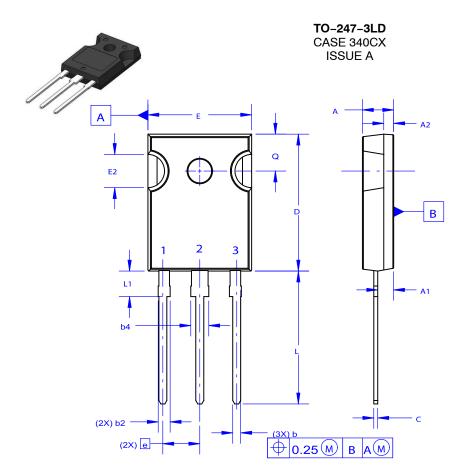
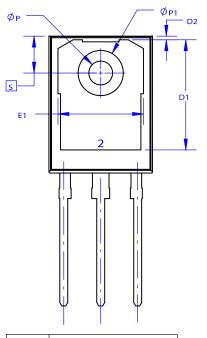


Figure 20. Transient Thermal Impedance of Diode



DATE 06 JUL 2020



NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

 B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	4.58	4.70	4.82	
A 1	2.20	2.40	2.60	
A2	1.40	1.50	1.60	
D	20.32	20.57	20.82	
Е	15.37	15.62	15.87	
E2	4.96	5.08	5.20	
е	~	5.56	~	
L	19.75	20.00	20.25	
L1	3.69	3.81	3.93	
ØΡ	3.51	3.58	3.65	
Q	5.34	5.46	5.58	
S	5.34	5.46	5.58	
b	1.17	1.26	1.35	
b2	1.53	1.65	1.77	
b4	2.42	2.54	2.66	
С	0.51	0.61	0.71	
D1	13.08	~	~	
D2	0.51	0.93	1.35	
E1	12.81	~	~	
ØP1	6.60	6.80	7.00	

DOCUMENT NUMBER:	98AON93302G	Electronic versions are uncontrolled except when accessed directly from the Document Repos Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1	

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMi., and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer p

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT: Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative